



IEC QUALITY ASSESSMENT SYSTEM (IECQ)
 covering Electronic Components,
 Assemblies, Related Materials and Processes
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Schedule of Scope to Certificate of Approval
Independent Testing Laboratory
 IECQ Certificate No.: IECQ-L ULTW 09.0023-05
 CB Certificate No.: T1130-7

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Appendix-1 (T1130-7)

Schedule of Scope to Certificate of Approval

Description test	Standard	Remark
Low Temperature Operation	IEC 60068-2-1	Or customer specified test conditions
Low Temperature Storage	IEC 60068-2-1	Or customer specified test conditions
High Temperature Operation	IEC 60068-2-2	Or customer specified test conditions
High Temperature Storage	IEC 60068-2-2	Or customer specified test conditions
High Temperature & High Humidity Operation	IEC 60068-2-3	Or customer specified test conditions
High Temperature & High Humidity Storage	IEC 60068-2-3	Or customer specified test conditions
Temperature Cycling	IEC 60068-2-14	Or customer specified test conditions
Thermal shock	IEC 60068-2-14	Or customer specified test conditions
Vibration (Sine wave)	IEC 60068-2-6	Or customer specified test conditions
Vibration (Random)	IEC 60068-2-34	Or customer specified test conditions
Mechanical Shock	IEC 60068-2-27	Or customer specified test conditions
Packing Vibration	ASTM D4728-06	Or customer specified test conditions

Technical Reviewer of DQS: Michael Chou Date: 11/17/2017

US-NAI, ECCC T.R.C.C. sign: *Joe Lee* Date: Nov. 20, 2017

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